# DATA SHEET 74LVT16244B 3.3V LVT 16-bit buffer/driver (3-State) **Prooduct specification** 1998 Oct 07 Supersedes data of 1998 Feb 19

INTEGRATED CIRCUITS



IC23 Data Handbook





# 74LVT16244B

### **FEATURES**

- 16-bit bus interface
- 3-State buffers
- Output capability: +64mA/-32mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Power-up 3-State
- No bus current loading when output is tied to 5V bus
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model

### QUICK REFERENCE DATA

### DESCRIPTION

The 74LVT16244B is a high-performance BiCMOS product designed for  $V_{CC}$  operation at 3.3V.

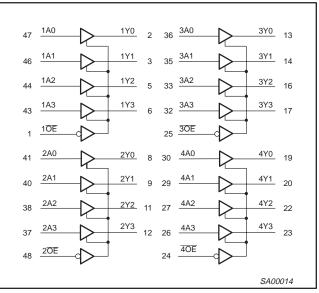
This device is a 16-bit buffer and line driver featuring non-inverting 3-State bus outputs. The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer.

SYMBOL	PARAMETER	CONDITIONS T <sub>amb</sub> = 25°C	TYPICAL	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay nAx to nYx	$C_L = 50 pF;$ $V_{CC} = 3.3 V$	1.8	ns
C <sub>IN</sub>	Input capacitance nOE	$V_{I} = 0V \text{ or } 3.0V$	3	pF
C <sub>OUT</sub>	Output capacitance	Outputs disabled; $V_0 = 0V \text{ or } 3.0V$	9	pF
I <sub>CCZ</sub>	Total supply current	Outputs disabled; $V_{CC} = 3.6V$	70	μΑ

### **ORDERING INFORMATION**

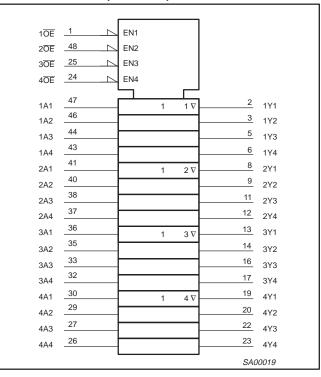
PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
48-Pin Plastic SSOP Type III	–40°C to +85°C	74LVT16244B DL	VT16244B DL	SOT370-1
48-Pin Plastic TSSOP Type II	–40°C to +85°C	74LVT16244B DGG	VT16244B DGG	SOT362-1

### LOGIC SYMBOL



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### LOGIC SYMBOL (IEEE/IEC)



### **PIN CONFIGURATION**

10E 1	48 20E
1Y0 2	47 1A0
1Y1 3	46 1A1
GND 4	45 GND
1Y2 5	44 1A2
1Y3 6	43 1A3
V <sub>CC</sub> 7	42 V <sub>CC</sub>
2Y0 8	41 2A0
2Y1 9	40 2A1
GND 10	39 GND
2Y2 11	38 2A2
2Y3 12	37 2A3
3Y0 13	36 3A0
3Y1 14	35 3A1
GND 15	34 GND
3Y2 16	33 3A2
3Y4 17	32 3A3
VCC 18	31 V <sub>CC</sub>
4Y0 19	30 4A0
4Y1 20	29 4A1
GND 21	28 GND
4Y2 22	27 4A2
4Y3 23	26 4A3
40E 24	25 3OE
	SA00013

### **PIN DESCRIPTION**

PIN NUMBER	SYMBOL	NAME AND FUNCTION
47, 46, 44, 43 41, 40, 38, 37 36, 35, 33, 32 30, 29, 27, 26	1A0 - 1A3, 2A0 - 2A3, 3A0 - 3A3, 4A0 - 4A3	Data inputs
2, 3, 5, 6 8, 9, 11, 12 13, 14, 16, 17 19, 20, 22, 23	1Y0 - 1Y3, 2Y0 - 2Y3, 3Y0 - 3Y3, 4Y0 - 4Y3	Data outputs
1, 48 25, 24	1 <u>0E</u> , 2 <u>0E</u> , 30E, 40E	Output enables
4, 10, 15, 21 28, 34, 39, 45	GND	Ground (0V)
7, 18, 31, 42	V <sub>CC</sub>	Positive supply voltage

### **FUNCTION TABLE**

INPUTS		OUTPUTS
nOE	nAx	nYx
L	L	L
L	Н	Н
Н	Х	Z

H = High voltage level L = Low voltage level

X = Don't care Z = High Impedance "off" state

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### ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>

SYMBOL	PARAMETER CONDITIONS		RATING	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5 to +4.6	V
I <sub>IK</sub>	DC input diode current	V <sub>1</sub> < 0	-50	mA
VI	DC input voltage <sup>3</sup>		-0.5 to +7.0	V
I <sub>ОК</sub>	DC output diode current	V <sub>O</sub> < 0	-50	mA
V <sub>OUT</sub>	DC output voltage <sup>3</sup>	Output in Off or High state	-0.5 to +7.0	V
		Output in Low state	128	
lout	DC output current	Output in High state	-64	mA
T <sub>stg</sub>	Storage temperature range		-65 to +150	°C

NOTES:

 Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	LIMITS		UNIT	
STMBOL		MIN	MAX     U       3.6		
V <sub>CC</sub>	DC supply voltage	2.7	3.6	V	
VI	Input voltage	0	5.5	V	
VIH	High-level input voltage	2.0		V	
V <sub>IL</sub>	Input voltage		0.8	V	
I <sub>OH</sub>	High-level output current		-32	mA	
	Low-level output current		32		
IOL	Low-level output current; current duty cycle $\leq$ 50%; f $\geq$ 1kHz		64	mA	
$\Delta t/\Delta v$	Input transition rise or fall rate; Outputs enabled		10	ns/V	
T <sub>amb</sub>	Operating free-air temperature range	-40	+85	°C	

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					LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS		Temp =	-40°C to	+85°C	UNIT
				MIN	TYP <sup>1</sup>	MAX	1
VIK	Input clamp voltage	V <sub>CC</sub> = 2.7V; I <sub>IK</sub> = -18mA			-0.85	-1.2	V
		V <sub>CC</sub> = 2.7 to 3.6V; I <sub>OH</sub> = -100μA		V <sub>CC</sub> -0.2	V <sub>CC</sub>		
V <sub>OH</sub>	High-level output voltage	V <sub>CC</sub> = 2.7V; I <sub>OH</sub> = -8mA		2.4	2.5		V
		V <sub>CC</sub> = 3.0V; I <sub>OH</sub> = -32mA		2.0	2.3		1
		V <sub>CC</sub> = 2.7V; I <sub>OL</sub> = 100µA			0.07	0.2	
		V <sub>CC</sub> = 2.7V; I <sub>OL</sub> = 24mA			0.3	0.5	1
V <sub>OL</sub>	Low-level output voltage	V <sub>CC</sub> = 3.0V; I <sub>OL</sub> = 16mA			0.25	0.4	V
		V <sub>CC</sub> = 3.0V; I <sub>OL</sub> = 32mA			0.3	0.5	1
		V <sub>CC</sub> = 3.0V; I <sub>OL</sub> = 64mA			0.4	0.55	1
		$V_{CC} = 3.6V; V_I = V_{CC} \text{ or } GND$	Control pins		0.1	±1.0	
		V <sub>CC</sub> = 0 or 3.6V; V <sub>I</sub> = 5.5V			0.4	10	μA
łı	Input leakage current	$V_{CC} = 3.6V; V_{I} = V_{CC}$			0.1	1	
		$V_{CC} = 3.6V; V_{I} = 0$	Data pins <sup>4</sup>		-0.4	-5	1
I <sub>OFF</sub>	Output off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$			0.1	±100	μΑ
		$V_{CC} = 3V; V_{I} = 0.8V$		75	135		
I <sub>HOLD</sub>	Bus Hold current A inputs <sup>6</sup>	$V_{CC} = 3V; V_1 = 2.0V$		-75	-135		μA
		$V_{CC} = 0V$ to 3.6V; $V_{CC} = 3.6V$		±500			1
I <sub>EX</sub>	Current into an output in the High state when $V_O > V_{CC}$	V <sub>O</sub> = 5.5V; V <sub>CC</sub> = 3.0V			50	125	μA
I <sub>PU/PD</sub>	Power up/down 3-State output current <sup>3</sup>	$V_{CC} \le 1.2V$ ; $V_O = 0.5V$ to $V_{CC}$ ; $V_I = GND$ OE/OE = Don't care	$V_{CC} \le 1.2V$ ; $V_O = 0.5V$ to $V_{CC}$ ; $V_I = GND$ or $V_{CC}$ OE/OE = Don't care		1	±100	μA
I <sub>OZH</sub>	3-State output High current	$V_{CC} = 3.6V; V_{O} = 3.0V; V_{I} = V_{IL} \text{ or } V_{IH}$			0.5	5	μA
I <sub>OZL</sub>	3-State output Low current	$V_{CC} = 3.6$ V; $V_{O} = 0.5$ V; $V_{I} = V_{IL}$ or $V_{IH}$			0.5	-5	μA
I <sub>CCH</sub>		$V_{CC}$ = 3.6V; Outputs High, $V_{I}$ = GND or V	/ <sub>CC</sub> , I <sub>O =</sub> 0		0.07	0.12	
I <sub>CCL</sub>	Quiescent supply current	$V_{CC} = 3.6V$ ; Outputs Low, $V_I = GND$ or $V_{CC}$ , $I_{O} = 0$			4.0	6.0	mA
I <sub>CCZ</sub>	1	V <sub>CC</sub> = 3.6V; Outputs Disabled; V <sub>I</sub> = GND	or V <sub>CC</sub> , $I_{O} = 0^5$		0.07	0.12	1
$\Delta I_{CC}$	Additional supply current per input pin <sup>2</sup>	$V_{CC}$ = 3V to 3.6V; One input at $V_{CC}$ -0.6V Other inputs at $V_{CC}$ or GND	3		0.1	0.2	mA

### **DC ELECTRICAL CHARACTERISTICS**

NOTES:

All typical values are at V<sub>CC</sub> = 3.3V and T<sub>amb</sub> = 25°C.
This is the increase in supply current for each input at the specified voltage level other than V<sub>CC</sub> or GND
This parameter is valid for any V<sub>CC</sub> between 0V and 1.2V with a transition time of up to 10msec. From V<sub>CC</sub> = 1.2V to V<sub>CC</sub> = 3.3V ± 0.3V a transition time of 100µsec is permitted. This parameter is valid for T<sub>amb</sub> = 25°C only.

4. Unused pins at V<sub>CC</sub> or GND.

5.  $I_{CCZ}$  is measured with outputs pulled to  $V_{CC}$  or GND.

6. This is the bus hold overdrive current required to force the input to the opposite logic state.

### **AC CHARACTERISTICS**

GND = 0V;  $t_R = t_F = 2.5ns$ ;  $C_L = 50pF$ ;  $R_L = 500\Omega$ ;  $T_{amb} = -40^{\circ}C$  to  $+85^{\circ}C$ .

				LIMITS			
SYMBOL	PARAMETER	WAVEFORM	٧ <sub>C0</sub>	c = 3.3V ±0.	.3V	$V_{CC} = 2.7V$	UNIT
			MIN	TYP <sup>1</sup>	MAX	MAX	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay nAx to nYx	1	0.5 0.5	1.8 1.7	3.2 3.2	4.0 4.0	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output enable time to High and Low level	2	1.0 1.0	2.3 2.1	4.0 4.0	5.0 5.3	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output disable time from High and Low Level	2	1.0 1.0	3.2 2.9	4.5 4.0	5.0 4.4	ns

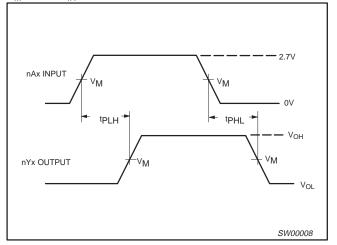
NOTE:

1. All typical values are at V<sub>CC</sub> = 3.3V and T<sub>amb</sub> =  $25^{\circ}$ C.

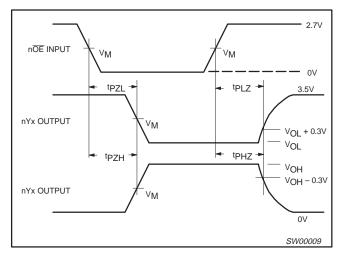
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### AC WAVEFORMS

 $V_{M} = 1.5V, V_{IN} = GND \text{ to } 3.0V$ 



Waveform 1. Input (nAx) to Output (nYx) Propagation Delays



Waveform 2. 3-State Output Enable and Disable Times

### **TEST CIRCUIT AND WAVEFORMS** 6V 0 VCC tw AMP (V) 90% 90% • OPEN NEGATIVE $^{\sf V}{\sf M}$ VN PULSE GND 10% 10% VIN VOUT RL ٥V PULSE D.U.T. tTHL (tF) tTLH (tR) GENERATOR ttlh (tr) RT tTHL (tF) RL AMP (V) 90% 90% POSITIVE ٧м Vм PULSE **Test Circuit for 3-State Outputs** 10% 10% 0V tw SWITCH POSITION $V_{M} = 1.5V$ SWITCH TEST Input Pulse Definition GND t<sub>PHZ</sub>/t<sub>PZH</sub> 6V t<sub>PLZ</sub>/t<sub>PZL</sub> t<sub>PLH</sub>/t<sub>PHL</sub> open DEFINITIONS R<sub>L</sub> = Load resistor; see AC CHARACTERISTICS for value. C<sub>L</sub> = Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value.

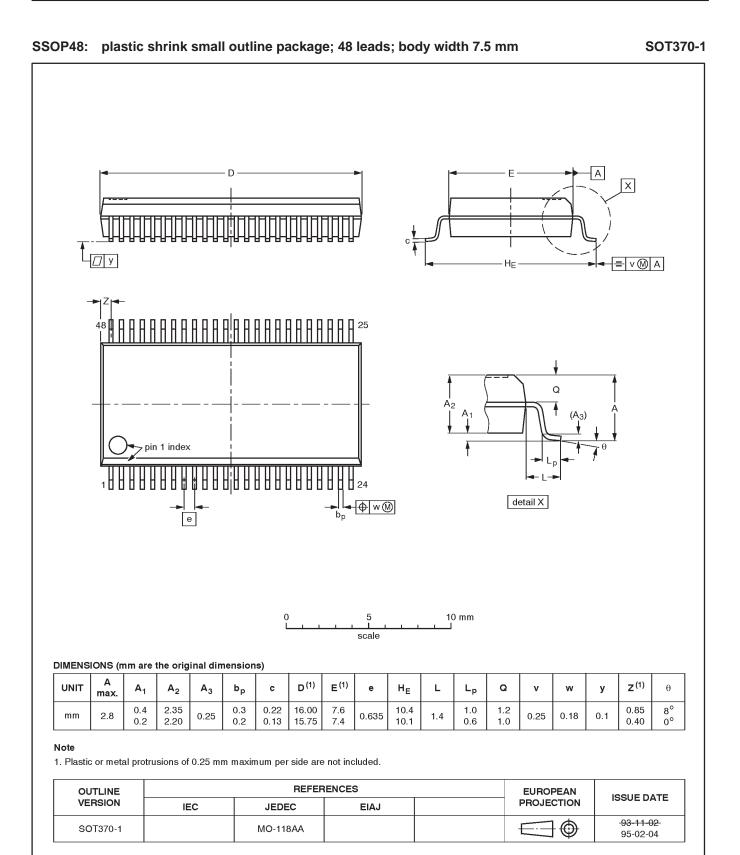
 $R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.

FAMILY	IN	PUT PULSE R	EQUIRE	MENTS	
FAMILI	Amplitude	Rep. Rate	t <sub>W</sub>	t <sub>R</sub>	t <sub>F</sub>
74LVT16	2.7V	≤10MHz	500ns	≤2.5ns	≤2.5ns

SW00003

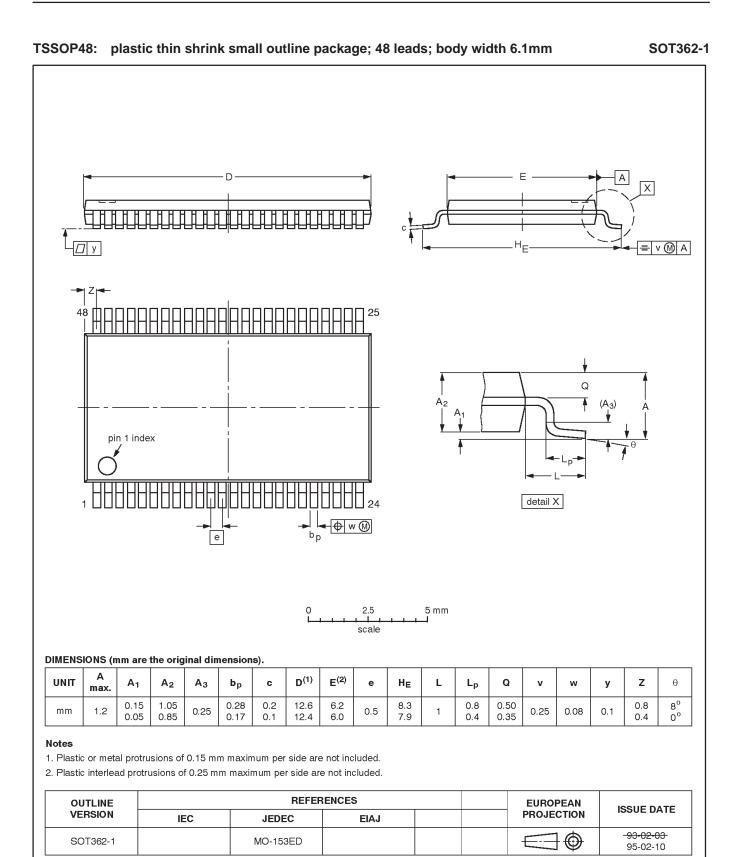
### Product specification

## 74LVT16244B



# Product specification

# 3.3V LVT 16-bit buffer/driver (3-State)



### 74LVT16244B

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NOTES

# 74LVT16244B

### Data sheet status

Data sheet status	Product status	Definition <sup>[1]</sup>
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
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